

NE5550779A

R09DS0040EJ0300 Rev.3.00 Mar 12, 2013

FEATURES

- High Output Power
- : P_{out} = 38.5 dBm TYP. (V_{DS} = 7.5 V, I_{Dset} = 140 mA, f = 460 MHz, P_{in} = 25 dBm)
- High power added efficiency
 - y : $\eta_{add} = 66\%$ TYP. (V_{DS} = 7.5 V, I_{Dset} = 140 mA, f = 460 MHz, P_{in} = 25 dBm) : G_L = 22.0 dB TYP. (V_{DS} = 7.5 V, I_{Dset} = 140 mA, f = 460 MHz, P_{in} = 10 dBm)
- High Linear gainHigh ESD tolerance
- Suitable for VHF to UHF-BAND Class-AB power amplifier.

APPLICATIONS

- 150 MHz Band Radio System
- 460 MHz Band Radio System
- 900 MHz Band Radio System

ORDERING INFORMATION

| Part Number | Order Number | Package | Marking | Supplying Form |
|----------------|------------------|-----------|---------|---|
| NE5550779A | NE5550779A-A | 79A | W8 | 12 mm wide embossed taping |
| | | (Pb-Free) | | Gate pin faces the perforation side of the tape |
| NE5550779A-T1 | NE5550779A-T1-A | | | 12 mm wide embossed taping |
| | | | | Gate pin faces the perforation side of the tape |
| | | | | Qty 1 kpcs/reel |
| NE5550779A-T1A | NE5550779A-T1A-A | | | 12 mm wide embossed taping |
| | | | | Gate pin faces the perforation side of the tape |
| | | | | Qty 5 kpcs/reel |

Remark To order evaluation samples, please contact your nearby sales office.

Part number for sample order: NE5550779A

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C, unless otherwise specified)

Operation in excess of any one of these parameters may result in permanent damage.

| Parameter | Symbol | Ratings | Unit |
|------------------------------|-----------------------|-------------|------|
| Drain to Source Voltage | V _{DS} | 30 | V |
| Gate to Source Voltage | V _{GS} | 6.0 | V |
| Drain Current | I _{DS} | 2.1 | А |
| Drain Current | I _{DS-pulse} | 4.2 | А |
| (50% Duty Pulsed) | | | |
| Total Power Dissipation Note | Ptot | 17.8 | W |
| Channel Temperature | T _{ch} | 150 | °C |
| Storage Temperature | T _{stg} | –55 to +150 | °C |

Note: Value at $T_C = 25^{\circ}C$

CAUTION

Observe precautions when handling because these devices are sensitive to electrostatic discharge.

The mark <R> shows major revised points.

The revised points can be easily searched by copying an "<R>" in the PDF file and specifying it in the "Find what:" field.



RECOMMENDED OPERATING RANGE (T_A = 25^{\circ}C)

| Parameter | Symbol | Test Conditions | MIN. | TYP. | MAX. | Unit |
|-------------------------|-----------------|--------------------------------------|------|------|------|------|
| Drain to Source Voltage | V _{DS} | | - | 7.5 | 9.0 | V |
| Gate to Source Voltage | V _{GS} | | 1.65 | 2.20 | 2.85 | V |
| Drain Current | I _{DS} | | - | 1.4 | - | Α |
| Input Power | Pin | f = 460 MHz, V _{DS} = 7.5 V | - | 25 | 30 | dBm |

ELECTRICAL CHARACTERISTICS (T_A = 25°C, unless otherwise specified)

| Parameter | Symbol | Test Conditions | MIN. | TYP. | MAX. | Unit |
|-----------------------------------|----------------------|---|------|-----------|------|----------|
| DC Characteristics | | 1 | 1 | 1 | | I |
| Gate to Source Leakage Current | I _{GSS} | V _{GS} = 6.0 V | - | - | 100 | nA |
| Drain to Source Leakage Current | I _{DSS} | V _{DS} = 25 V | - | - | 10 | μA |
| (Zero Gate Voltage Drain Current) | | | | | | |
| Gate Threshold Voltage | V _{th} | V _{DS} = 7.5 V, I _{DS} = 1.0 mA | 1.15 | 1.65 | 2.25 | V |
| Drain to Source Breakdown Voltage | BV _{DSS} | I _{DS} = 10 μA | 25 | 38 | - | V |
| Transconductance | Gm | V_{DS} = 7.5 V, I_{DS} = 490±70 mA | 1.26 | 1.54 | 2.03 | S |
| Thermal Resistance | R _{th} | Channel to Case | - | 7.0 | - | °C/W |
| RF Characteristics | | | | | | |
| Output Power | Pout | f = 460 MHz, V _{DS} = 7.5 V, | 37.0 | 38.5 | - | dBm |
| Drain Current | I _{DS} | P _{in} = 25 dBm, | - | 1.38 | - | Α |
| Power Drain Efficiency | η_{d} | I _{Dset} = 140 mA (RF OFF) | - | 68 | - | % |
| Power Added Efficiency | η_{add} | | - | 66 | - | % |
| Linear Gain | GL Note 1 | | - | 22.0 | - | dB |
| Load VSWR Tolerance | Note 2 | f = 460 MHz, V _{DS} = 9.0 V, | 1 | lo Destro | у | |
| | | P _{in} = 25 dBm, | | | | |
| | | I _{Dset} = 140 mA (RF OFF) | | | | |
| | | Load VSWR=20:1(All Phase) | | | | |
| Output Power | Pout | f = 157 MHz, V _{DS} = 7.5 V, | _ | 38.5 | - | dBm |
| Drain Current | I _{DS} | P _{in} = 23 dBm, | _ | 1.36 | - | Α |
| Power Drain Efficiency | η_{d} | I _{Dset} = 140 mA (RF OFF) | _ | 69 | - | % |
| Power Added Efficiency | η_{add} | | - | 67 | - | % |
| Linear Gain | GL Note 3 | | - | 24.0 | - | dB |
| Output Power | Pout | f = 900 MHz, V _{DS} = 7.5 V, | _ | 37.4 | Ι | dBm |
| Drain Current | I _{DS} | P _{in} = 27 dBm, | - | 1.26 | - | Α |
| Power Drain Efficiency η | | I _{Dset} = 140 mA (RF OFF) | - | 58 | - | % |
| Power Added Efficiency | η_{add} | J | - | 53 | - | % |
| Linear Gain | G∟ ^{Note 4} | | - | 17.0 | - | dB |

Notes: 1. P_{in} = 10 dBm

2. These characteristics values are measurement using measurement tools especially by RENESAS.

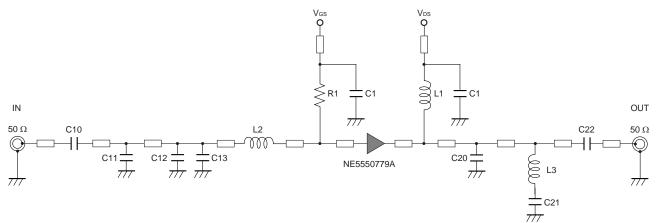
3. P_{in} = 5 dBm

4. P_{in} = 10 dBm

Remark DC performance is 100% testing. RF performance is testing several samples per wafer. A wafer rejection criterion for standard devices is 1 reject for several samples.



TEST CIRCUIT SCHEMATIC FOR 460 MHz

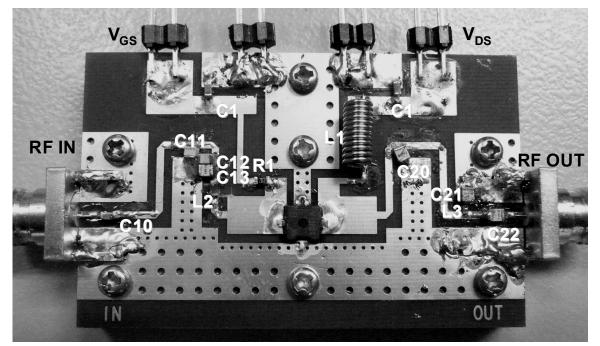


COMPONENTS OF TEST CIRCUIT FOR MEASURING ELECTRICAL CHARACTERISTICS

| Symbol | Value | Туре | Maker |
|---------------|--------------|--|--------------------------------|
| C1 | 1 <i>μ</i> F | GRM188B31C105KA92 | Murata |
| C10 | 27 pF | GRM1882C1H270JA01 | Murata |
| C11 | 2.7 pF | ATC100A2R7JW | American Technical Ceramics |
| C12 | 12 pF | ATC100A120BW | American Technical Ceramics |
| C13 | 12 pF | ATC100A120BW | American Technical Ceramics |
| C20 | 24 pF | ATC100A240JW | American Technical Ceramics |
| C21 | 6.8 pF | ATC100A6R8BW | American Technical Ceramics |
| C22 | 100 pF | ATC100A101JW | American Technical Ceramics |
| R1 | 2 kΩ | 1/10 W Chip Resistor RK73B1JTTD202J | KOA |
| L1 | 114 nH | ϕ 0.5 mm, ϕ D = 3 mm, 10 Turns | Ohesangyou |
| L2 | 4.7 nH | LQW18AN4R7NG00 | Murata |
| L3 | 3.0 nH | LQP15MN3N0B02 | Murata |
| PCB | - | R1766, t = 0.4 mm, <i>ε</i> r = 4.5, size = 30 × 48 mm | Panasonic |
| SMA Connecter | - | WAKA 01K0790-20 | WAKA |



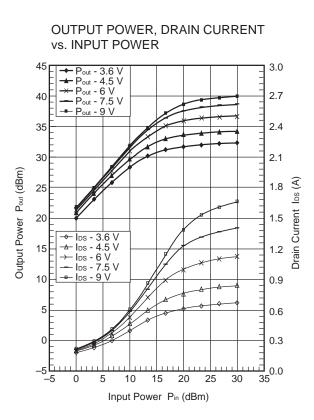
COMPONENT LAYOUT OF TEST CIRCUIT FOR 460 MHz





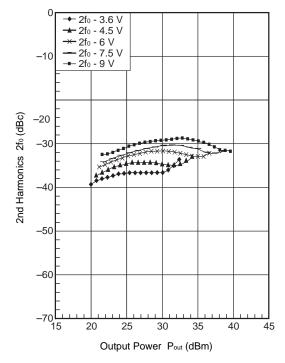
TYPICAL CHARACTERISTICS 1 ($T_A = 25^{\circ}C$)

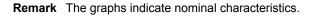
- R: f = 460MHz, $V_{DS} = 3.6/4.5/6/7.5/9$ V, $I_{Dset} = 140$ mA, $P_{in} = 0$ to 30 dBm
- IM: f1 = 460MHz, f2 = 461 MHz, V_{DS} = 3.6/4.5/6/7.5/9 V, I_{Dset} = 140mA, P_{out} (2 tone) = 12 to 37 dBm



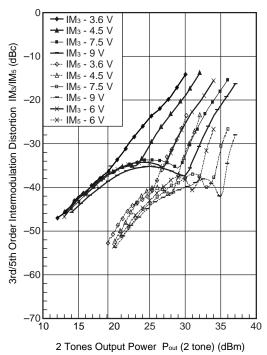
POWER GAIN, POWER ADDED EFFICIENCY vs. INPUT POWER 80 40 ← Gp - 3.6 V ____ G_P - 4.5 V × G_p - 6 V 35 70 Gp - 7.5 V -G_p - 9 V η add - 3.6 V 🛨 η add - 4.5 V 30 60 ×− η add - 6 V η_{add} (%) **-**η add - 7.5 ∖ **–** η add - 9 V G (dB) 25 50 Power Added Efficiency Power Gain 20 40 30 15 10 20 5 10 οĽ 0 0 5 10 15 20 25 30 35 -5 Input Power Pin (dBm)

2fo vs. OUTPUT POWER



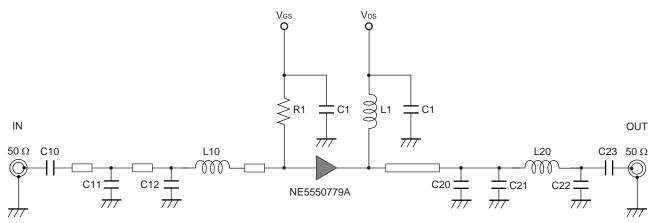


IM3/IM5 vs. 2 TONES OUTPUT POWER





TEST CIRCUIT SCHEMATIC FOR 157 MHz



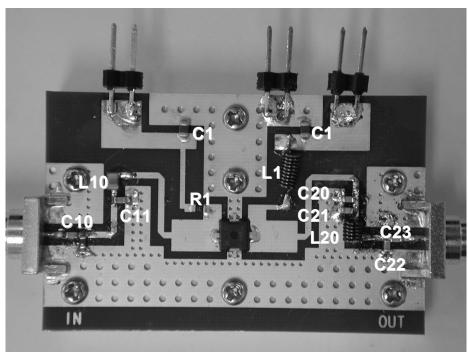
COMPONENTS OF TEST CIRCUIT FOR MEASURING ELECTRICAL CHARACTERISTICS

| Symbol | Value | Туре | Maker |
|---------------|--------------|--|------------|
| C1 | 1 <i>μ</i> F | GRM31MB11E105KA01 | Murata |
| C10 | 100 pF | GQM1882C1H101JB01 | Murata |
| C11 | 5.6 pF | GQM1882C2A5R6DB01 | Murata |
| C12 | 39 pF | GQM1882C1H390JB01 | Murata |
| C20 | 22 pF | GRM1882C1H220JA01 | Murata |
| C21 | 68 pF | GQM1882C1H680JB01 | Murata |
| C22 | 15 pF | GQM1882C1H150JA01 | Murata |
| C23 | 100 pF | GQM1882C1H101JB01 | Murata |
| R1 | 5.1 kΩ | 1/10 W Chip Resistor | ROAM |
| | | MCR03J103 | |
| L1 | 74.7 nH | ϕ 0.4 mm, ϕ D = 2 mm, 10 Turns | Ohesangyou |
| L10 | 27 nH | LLQ2012-F27N | Toko |
| L20 | 29.8 nH | ϕ 0.4 mm, ϕ D = 2 mm, 5 Turns | Ohesangyou |
| PCB | - | R1766, t = 0.4 mm, <i>e</i> r = 4.5, size = 30 × 48 mm | Panasonic |
| SMA Connecter | _ | WAKA 01K0790-20 | WAKA |

<R>



COMPONENT LAYOUT OF TEST CIRCUIT FOR 157 MHz



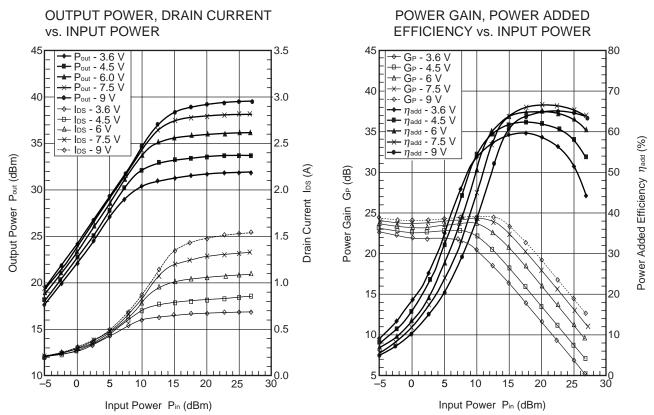
OUT

IN



TYPICAL CHARACTERISTICS 2 ($T_A = 25^{\circ}C$)

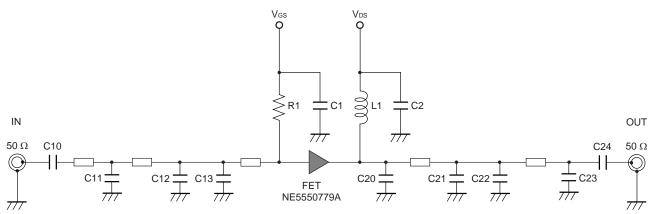
RF: $f = 157 \text{ MHz}, V_{DS} = 3.6/4.5/6/7.5/9 \text{ V}, I_{Dset} = 40 \text{ mA}, P_{in} = -10 \text{ to } 20 \text{ dBm}$



Remark The graphs indicate nominal characteristics.



TEST CIRCUIT SCHEMATIC FOR 900 MHz

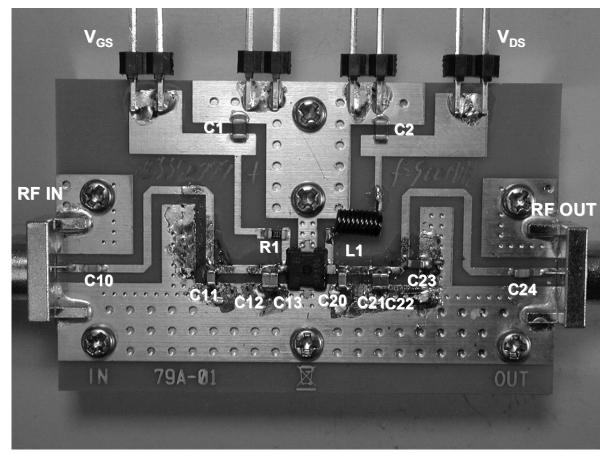


COMPONENTS OF TEST CIRCUIT FOR MEASURING ELECTRICAL CHARACTERISTICS

| Symbol | Value | Туре | Maker |
|---------------|--------------|--|------------|
| C10 | 27 pF | GQM1882C1H270JB01 | Murata |
| C11 | 6.8 pF | GQM1882C2A6R8DB01 | Murata |
| C12 | 15 pF | GQM1882C1H150JB01 | Murata |
| C13 | 18 pF | GQM1882C1H180JB01 | Murata |
| C20 | 8.2 pF | GQM1882C1H8R2DB01 | Murata |
| C21 | 3.9 pF | GQM1883C2A3R9CB01 | Murata |
| C22 | 1.5 pF | GQM1884C2A1R5CB01 | Murata |
| C23 | 8.2 pF | GQM1882C1H8R2DB01 | Murata |
| C24 | 100 pF | GQM1882C1H101JB01 | Murata |
| C1 | 1 <i>µ</i> F | GRM21BB31H105KA2L | Murata |
| C2 | 1 <i>µ</i> F | GRM21BB31H105KA2L | Murata |
| L1 | 74.7 nH | D20-74N7 | Ohesangyou |
| R1 | 20 kΩ | MCR03J203 | Rohm |
| PCB | _ | R1766, t = 0.8 mm, <i>ε</i> r = 4.8, size = 30 × 40 mm | Panasonic |
| SMA Connecter | _ | WAKA 01K0790-20 | WAKA |



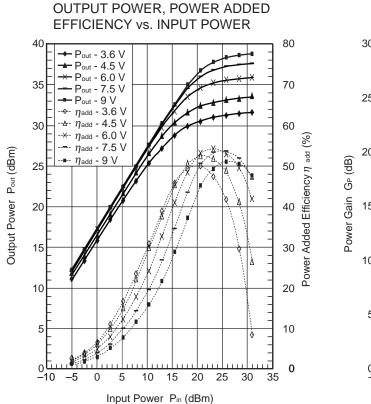
COMPONENT LAYOUT OF TEST CIRCUIT FOR 900 MHz



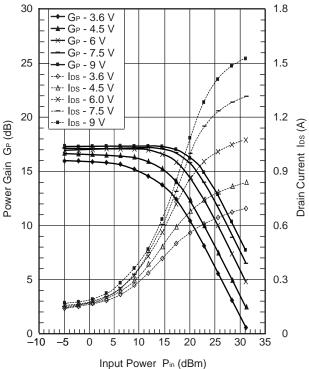


TYPICAL CHARACTERISTICS 3 ($T_A = 25^{\circ}C$)

RF: f = 900 MHz, V_{DS} = 3.6/4.5/6/7.5/9 V, I_{Dset} = 40 mA, P_{in} = -5 to 30 dBm







POWER GAIN, DRAIN CURRENT

vs. INPUT POWER



S-PARAMETERS

S-parameters and noise parameters are provided on our web site in a form (S2P) that enables direct import of the parameters to microwave circuit simulators without the need for keyboard inputs.

Click here to download S-parameters.

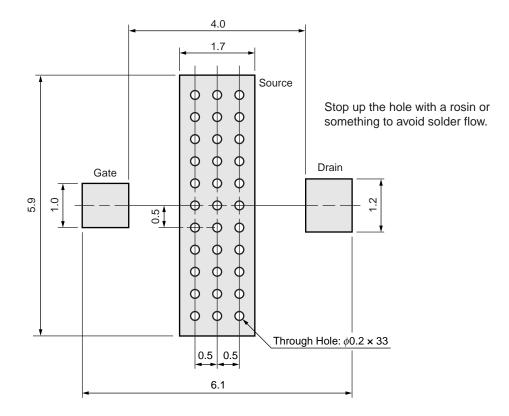
 $[\mathsf{Products}] \to [\mathsf{RF} \ \mathsf{Devices}] \to [\mathsf{Device} \ \mathsf{Parameters}]$

URL http://www.renesas.com/products/microwave/



MOUNTING LAYOUT PAD DIMENSIONS

79A (UNIT: mm)

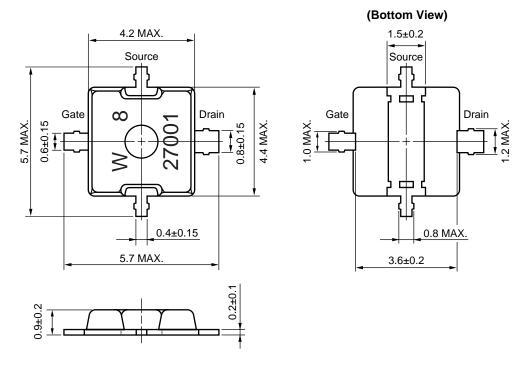


Remark The mounting pad layout in this document is for reference only. When designing PCB, please consider workability of mounting, solder joint reliability, prevention of solder bridge and so on, in order to optimize the design.



PACKAGE DIMENSIONS

79A (UNIT: mm)





RECOMMENDED SOLDERING CONDITIONS

This product should be soldered and mounted under the following recommended conditions. For soldering methods and conditions other than those recommended below, contact your nearby sales office.

| Soldering Method | Soldering Conditions | | Condition Symbol |
|------------------|--|-----------------------|------------------|
| Infrared Reflow | Peak temperature (package surface temperature) | : 260°C or below | IR260 |
| | Time at peak temperature | : 10 seconds or less | |
| | Time at temperature of 220°C or higher | : 60 seconds or less | |
| | Preheating time at 120 to 180°C | : 120±30 seconds | |
| | Maximum number of reflow processes | : 3 times | |
| | Maximum chlorine content of rosin flux (% mass) | : 0.2% (Wt.) or below | |
| Wave Soldering | Peak temperature (molten solder temperature) | : 260°C or below | WS260 |
| | Time at peak temperature | : 10 seconds or less | |
| | Preheating temperature (package surface temperative) | ature) | |
| | | : 120°C or below | |
| | Maximum number of flow processes | : 1 time | |
| | Maximum chlorine content of rosin flux (% mass) | : 0.2% (Wt.) or below | |
| Partial Heating | Peak temperature (terminal temperature) | : 350°C or below | HS350 |
| | Soldering time (per side of device) | : 3 seconds or less | |
| | Maximum chlorine content of rosin flux (% mass) | : 0.2% (Wt.) or below | |

CAUTION

Do not use different soldering methods together (except for partial heating).



Revision History

NE5550779A Data Sheet

| | | Description | |
|------|--------------|-------------|--|
| Rev. | Date | Page | Summary |
| 1.00 | Apr 26, 2012 | - | First edition issued |
| 2.00 | Jul 04, 2012 | p.2 | Modification of ELECTRICAL CHARACTERISTICS |
| | | p.6 | Modification of COMPONENTS OF TEST CIRCUIT FOR MEASURING ELECTRICAL CHARACTERISTICS |
| 3.00 | Mar 12, 2013 | P3 | Modification of COMPONENTS OF TEST CIRCUIT FOR MEASURING ELECTRICAL CHARACTERISTICS |
| | | P6 | Modification of COMPONENTS OF TEST CIRCUIT FOR MEASURING ELECTRICAL CHARACTERISTICS |
| | | P9 | Modification of COMPONENTS OF TEST CIRCUIT FOR MEASURING ELECTRICAL CHARACTERISTICS |

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